

<b>Notice of References Cited</b>	Application/Control No. <b>09/188,190</b>	Applicant(s)/Patent Under Reexam <b>Kaneko et al.</b>	
	Examiner <b>Tu M. Nguyen</b>	Art Unit <b>3748</b>	Page 1 of 1

**U.S. PATENT DOCUMENTS**

		Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
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	B	5,201,802	4/1993	Hirota et al.	60	277
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**NON-PATENT DOCUMENTS**

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